

Notice of References Cited

Application/Control No.

10/580,856

Applicant(s)/Patent Under

Reexamination

DEFAYE ET AL.

Examiner

Jonathan S. Lau

Art Unit

1623

Page 1 of 1

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	L US-			
	M US-			

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